

LM555 Timer

Check for Samples: [LM555](#)

FEATURES

- Direct Replacement for SE555/NE555
- Timing from Microseconds through Hours
- Operates in Both Astable and Monostable Modes
- Adjustable Duty Cycle
- Output Can Source or Sink 200 mA
- Output and Supply TTL Compatible
- Temperature Stability Better than 0.005% per °C
- Normally On and Normally Off Output
- Available in 8-pin VSSOP Package

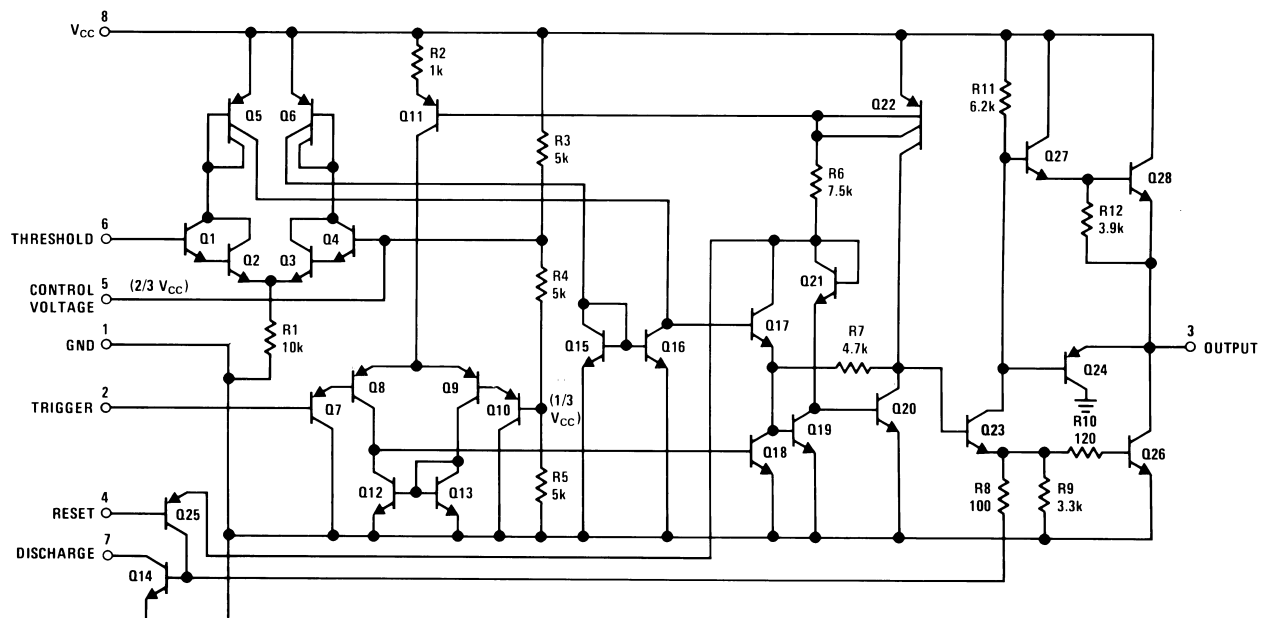
DESCRIPTION

The LM555 is a highly stable device for generating accurate time delays or oscillation. Additional terminals are provided for triggering or resetting if desired. In the time delay mode of operation, the time is precisely controlled by one external resistor and capacitor. For astable operation as an oscillator, the free running frequency and duty cycle are accurately controlled with two external resistors and one capacitor. The circuit may be triggered and reset on falling waveforms, and the output circuit can source or sink up to 200mA or drive TTL circuits.

APPLICATIONS

- Precision Timing
- Pulse Generation
- Sequential Timing
- Time Delay Generation
- Pulse Width Modulation
- Pulse Position Modulation
- Linear Ramp Generator

Schematic Diagram



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Connection Diagram

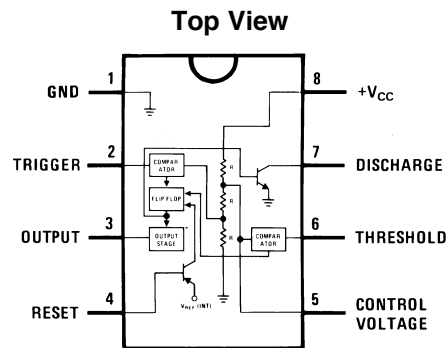


Figure 1. PDIP, SOIC, and VSSOP Packages



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings⁽¹⁾⁽²⁾

Supply Voltage	+18V
Power Dissipation ⁽³⁾	
LM555CM, LM555CN ⁽⁴⁾	1180 mW
LM555CMM	613 mW
Operating Temperature Ranges	
LM555C	0°C to +70°C
Storage Temperature Range	–65°C to +150°C
Soldering Information	
PDIP Package	
Soldering (10 Seconds)	260°C
Small Outline Packages (SOIC and VSSOP)	
Vapor Phase (60 Seconds)	215°C
Infrared (15 Seconds)	220°C

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which ensures specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given, however, the typical value is a good indication of device performance.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications.
- (3) For operating at elevated temperatures the device must be derated above 25°C based on a +150°C maximum junction temperature and a thermal resistance of 106°C/W (PDIP), 170°C/W (SOIC-8), and 204°C/W (VSSOP) junction to ambient.
- (4) Refer to RETS555X drawing of military LM555H and LM555J versions for specifications.

Electrical Characteristics ^{(1) (2)}

(T_A = 25°C, V_{CC} = +5V to +15V, unless otherwise specified)

Parameter	Test Conditions	Limits			Units
		LM555C			
		Min	Typ	Max	
Supply Voltage		4.5		16	V
Supply Current	V _{CC} = 5V, R _L = ∞ V _{CC} = 15V, R _L = ∞ (Low State) ⁽³⁾		3 10	6 15	mA
Timing Error, Monostable	R _A = 1k to 100kΩ, C = 0.1μF, ⁽⁴⁾		1		%
Initial Accuracy			50		ppm/°C
Drift with Temperature			1.5		%
Accuracy over Temperature			0.1		%/V
Timing Error, Astable	R _A , R _B = 1k to 100kΩ, C = 0.1μF, ⁽⁴⁾		2.25		%
Initial Accuracy			150		ppm/°C
Drift with Temperature			3.0		%
Accuracy over Temperature			0.30		%/V
Threshold Voltage			0.667		x V _{CC}
Trigger Voltage	V _{CC} = 15V		5		V
	V _{CC} = 5V		1.67		V
Trigger Current			0.5	0.9	μA
Reset Voltage		0.4	0.5	1	V
Reset Current			0.1	0.4	mA
Threshold Current	⁽⁵⁾		0.1	0.25	μA
Control Voltage Level	V _{CC} = 15V	9	10	11	V
	V _{CC} = 5V	2.6	3.33	4	
Pin 7 Leakage Output High			1	100	nA
Pin 7 Sat ⁽⁶⁾					
Output Low	V _{CC} = 15V, I ₇ = 15mA		180		mV
Output Low	V _{CC} = 4.5V, I ₇ = 4.5mA		80	200	mV
Output Voltage Drop (Low)	V _{CC} = 15V				
	I _{SINK} = 10mA		0.1	0.25	V
	I _{SINK} = 50mA		0.4	0.75	V
	I _{SINK} = 100mA		2	2.5	V
	I _{SINK} = 200mA		2.5		V
	V _{CC} = 5V				
	I _{SINK} = 8mA				V
	I _{SINK} = 5mA		0.25	0.35	V

(1) All voltages are measured with respect to the ground pin, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which ensures specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given, however, the typical value is a good indication of device performance.

(3) Supply current when output high typically 1 mA less at V_{CC} = 5V.

(4) Tested at V_{CC} = 5V and V_{CC} = 15V.

(5) This will determine the maximum value of R_A + R_B for 15V operation. The maximum total (R_A + R_B) is 20MΩ.

(6) No protection against excessive pin 7 current is necessary providing the package dissipation rating will not be exceeded.

Electrical Characteristics ⁽¹⁾ ⁽²⁾ **(continued)**(T_A = 25°C, V_{CC} = +5V to +15V, unless otherwise specified)

Parameter	Test Conditions	Limits			Units
		LM555C			
		Min	Typ	Max	
Output Voltage Drop (High)	I _{SOURCE} = 200mA, V _{CC} = 15V		12.5		V
	I _{SOURCE} = 100mA, V _{CC} = 15V	12.75	13.3		V
	V _{CC} = 5V	2.75	3.3		V
Rise Time of Output			100		ns
Fall Time of Output			100		ns

Typical Performance Characteristics

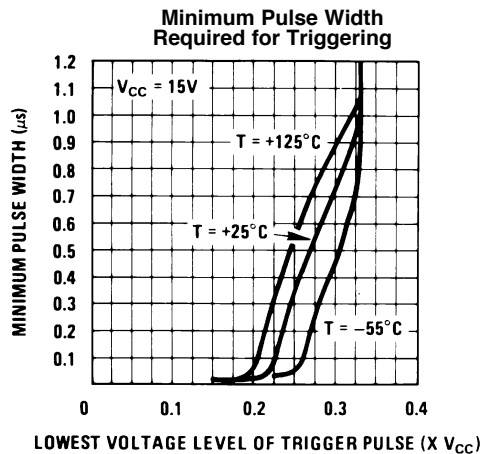


Figure 2.

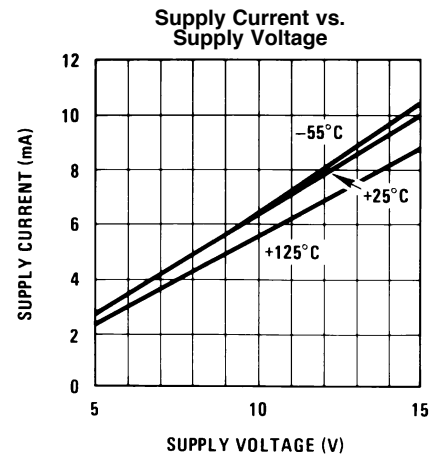


Figure 3.

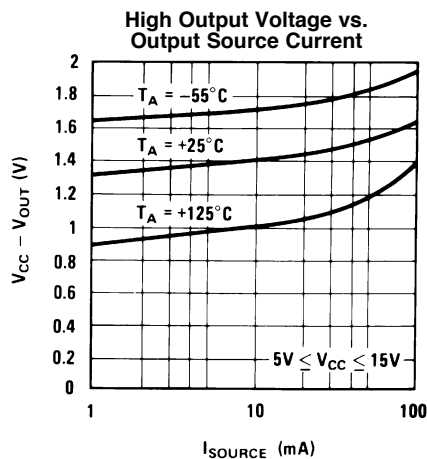


Figure 4.

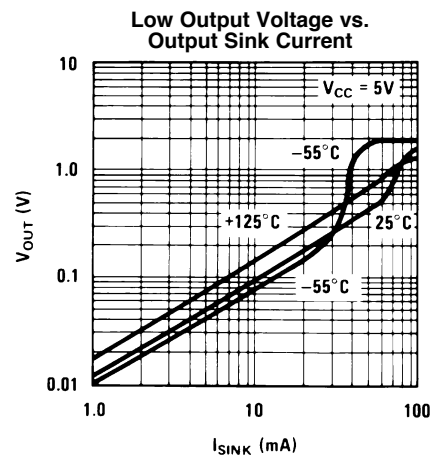


Figure 5.

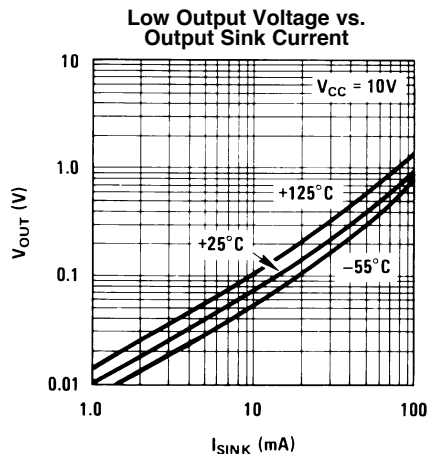


Figure 6.

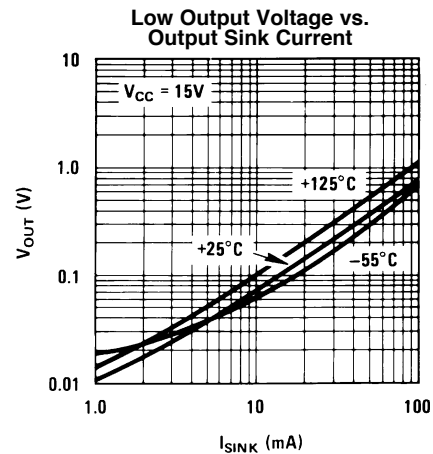


Figure 7.

Typical Performance Characteristics (continued)

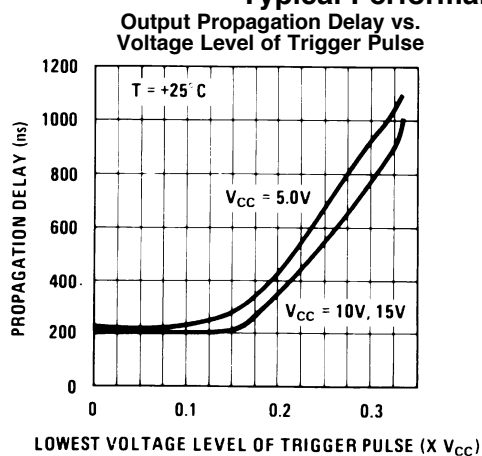


Figure 8.

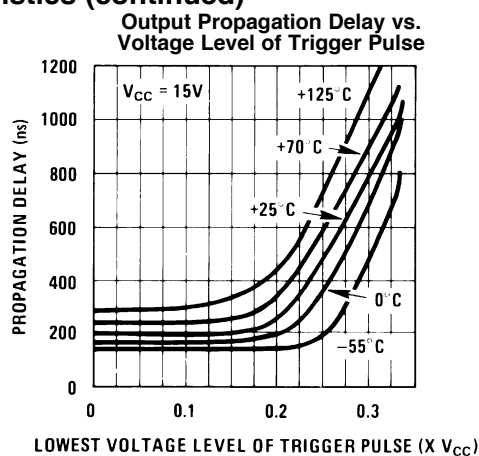


Figure 9.

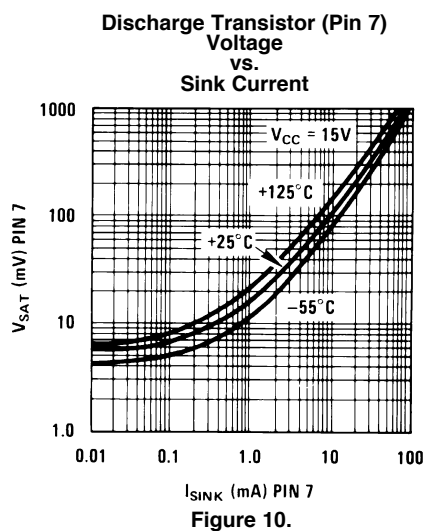


Figure 10.

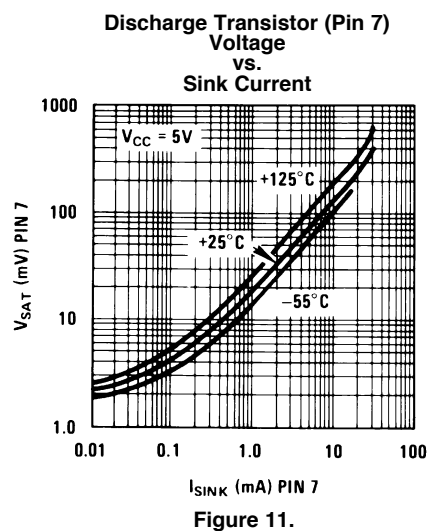


Figure 11.

APPLICATIONS INFORMATION

MONOSTABLE OPERATION

In this mode of operation, the timer functions as a one-shot (Figure 12). The external capacitor is initially held discharged by a transistor inside the timer. Upon application of a negative trigger pulse of less than $\frac{1}{3} V_{CC}$ to pin 2, the flip-flop is set which both releases the short circuit across the capacitor and drives the output high.

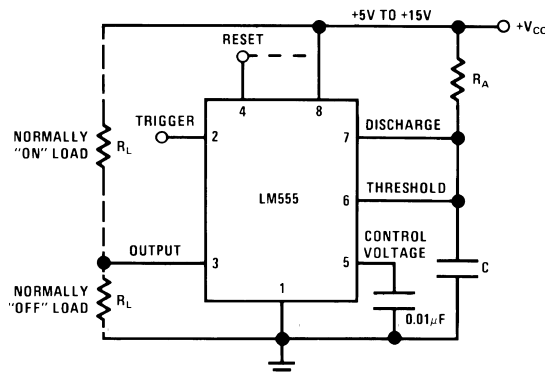


Figure 12. Monostable

The voltage across the capacitor then increases exponentially for a period of $t = 1.1 R_A C$, at the end of which time the voltage equals $\frac{2}{3} V_{CC}$. The comparator then resets the flip-flop which in turn discharges the capacitor and drives the output to its low state. Figure 13 shows the waveforms generated in this mode of operation. Since the charge and the threshold level of the comparator are both directly proportional to supply voltage, the timing interval is independent of supply.



$V_{CC} = 5V$
TIME = 0.1 ms/DIV.
 $R_A = 9.1k\Omega$
 $C = 0.01\mu F$

Top Trace: Input 5V/Div.
Middle Trace: Output 5V/Div.
Bottom Trace: Capacitor Voltage 2V/Div.

Figure 13. Monostable Waveforms

During the timing cycle when the output is high, the further application of a trigger pulse will not effect the circuit so long as the trigger input is returned high at least $10\mu s$ before the end of the timing interval. However the circuit can be reset during this time by the application of a negative pulse to the reset terminal (pin 4). The output will then remain in the low state until a trigger pulse is again applied.

When the reset function is not in use, it is recommended that it be connected to V_{CC} to avoid any possibility of false triggering.

Figure 14 is a nomograph for easy determination of R , C values for various time delays.

NOTE

In monostable operation, the trigger should be driven high before the end of timing cycle.

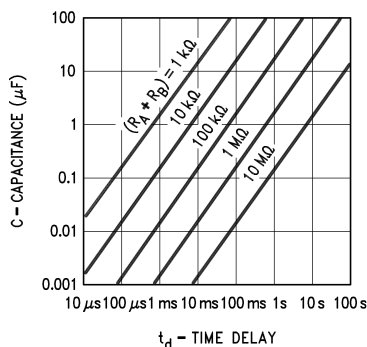


Figure 14. Time Delay

ASTABLE OPERATION

If the circuit is connected as shown in Figure 15 (pins 2 and 6 connected) it will trigger itself and free run as a multivibrator. The external capacitor charges through $R_A + R_B$ and discharges through R_B . Thus the duty cycle may be precisely set by the ratio of these two resistors.

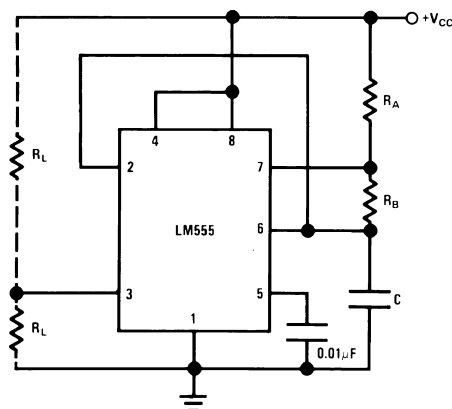
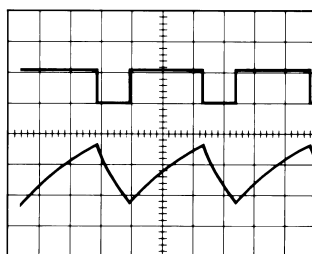


Figure 15. Astable

In this mode of operation, the capacitor charges and discharges between $1/3 V_{CC}$ and $2/3 V_{CC}$. As in the triggered mode, the charge and discharge times, and therefore the frequency are independent of the supply voltage.

Figure 16 shows the waveforms generated in this mode of operation.



$V_{CC} = 5V$
 TIME = 20μs/DIV.
 $R_A = 3.9k\Omega$
 $R_B = 3k\Omega$
 $C = 0.01\mu F$

Top Trace: Output 5V/Div.
 Bottom Trace: Capacitor Voltage 1V/Div.

Figure 16. Astable Waveforms

The charge time (output high) is given by:

$$t_1 = 0.693 (R_A + R_B) C \quad (1)$$

And the discharge time (output low) by:

$$t_2 = 0.693 (R_B) C \quad (2)$$

Thus the total period is:

$$T = t_1 + t_2 = 0.693 (R_A + 2R_B) C \quad (3)$$

The frequency of oscillation is:

$$f = \frac{1}{T} = \frac{1.44}{(R_A + 2R_B) C} \quad (4)$$

Figure 17 may be used for quick determination of these RC values.

The duty cycle is:

$$D = \frac{R_B}{R_A + 2R_B} \quad (5)$$

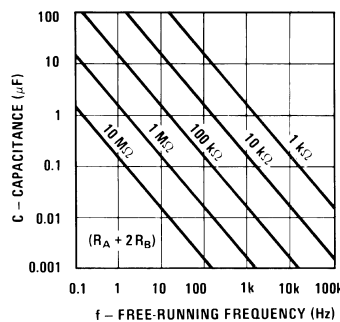
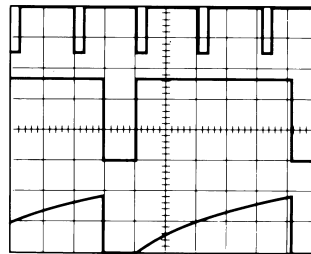


Figure 17. Free Running Frequency

FREQUENCY DIVIDER

The monostable circuit of Figure 12 can be used as a frequency divider by adjusting the length of the timing cycle. Figure 18 shows the waveforms generated in a divide by three circuit.



$V_{CC} = 5V$
 $TIME = 20\mu s/DIV.$
 $R_A = 9.1k\Omega$
 $C = 0.01\mu F$

Top Trace: Input 4V/Div.
 Middle Trace: Output 2V/Div.
 Bottom Trace: Capacitor 2V/Div.

Figure 18. Frequency Divider

PULSE WIDTH MODULATOR

When the timer is connected in the monostable mode and triggered with a continuous pulse train, the output pulse width can be modulated by a signal applied to pin 5. Figure 19 shows the circuit, and in Figure 20 are some waveform examples.

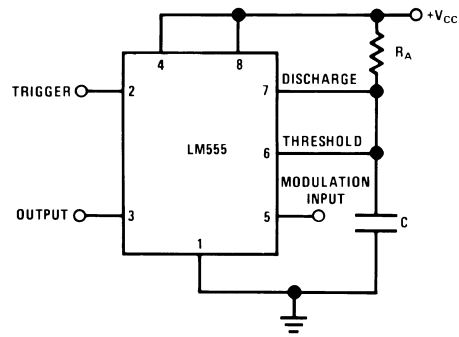
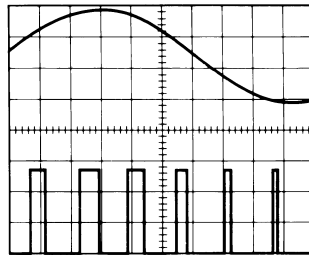


Figure 19. Pulse Width Modulator



$V_{CC} = 5V$ Top Trace: Modulation 1V/Div.
 TIME = 0.2 ms/DIV. Bottom Trace: Output Voltage 2V/Div.
 $R_A = 9.1k\Omega$
 $C = 0.01\mu F$

Figure 20. Pulse Width Modulator

PULSE POSITION MODULATOR

This application uses the timer connected for astable operation, as in [Figure 21](#), with a modulating signal again applied to the control voltage terminal. The pulse position varies with the modulating signal, since the threshold voltage and hence the time delay is varied. [Figure 22](#) shows the waveforms generated for a triangle wave modulation signal.

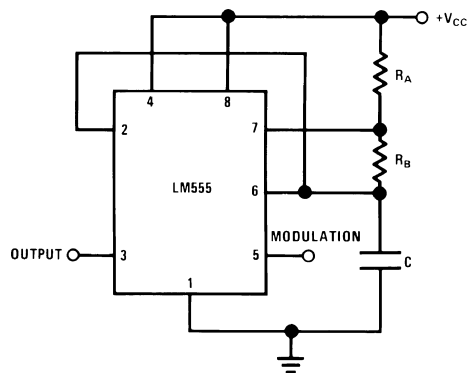
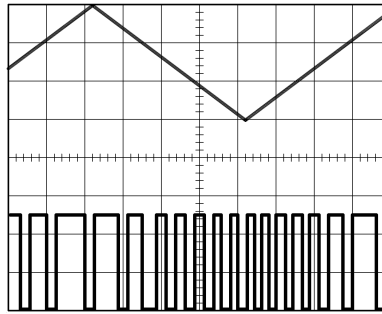


Figure 21. Pulse Position Modulator



$V_{CC} = 5V$
 $TIME = 0.1 \text{ ms/DIV.}$
 $R_A = 3.9k\Omega$
 $R_B = 3k\Omega$
 $C = 0.01\mu F$

Top Trace: Modulation Input 1V/Div.
 Bottom Trace: Output 2V/Div.

Figure 22. Pulse Position Modulator

LINEAR RAMP

When the pullup resistor, R_A , in the monostable circuit is replaced by a constant current source, a linear ramp is generated. [Figure 23](#) shows a circuit configuration that will perform this function.

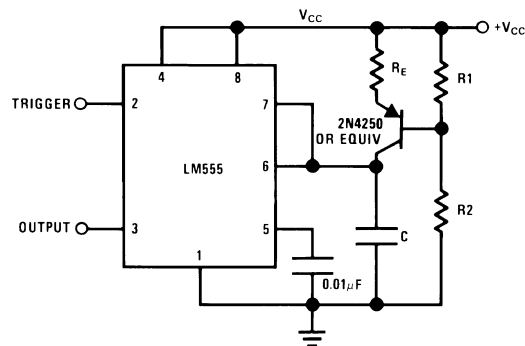


Figure 23.

[Figure 24](#) shows waveforms generated by the linear ramp.

The time interval is given by:

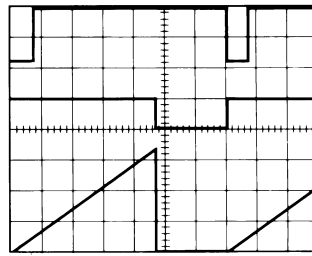
$$T = \frac{2/3 V_{CC} R_E (R_1 + R_2) C}{R_1 V_{CC} - V_{BE} (R_1 + R_2)}$$

$$V_{BE} \approx 0.6V$$

$$V_{BE} \approx 0.6V$$

(6)

(7)



$V_{CC} = 5V$
 TIME = 20 μs /DIV.
 $R_1 = 47k\Omega$
 $R_2 = 100k\Omega$
 $R_E = 2.7k\Omega$
 $C = 0.01\mu F$

Top Trace: Input 3V/Div.
 Middle Trace: Output 5V/Div.
 Bottom Trace: Capacitor Voltage 1V/Div.

Figure 24. Linear Ramp

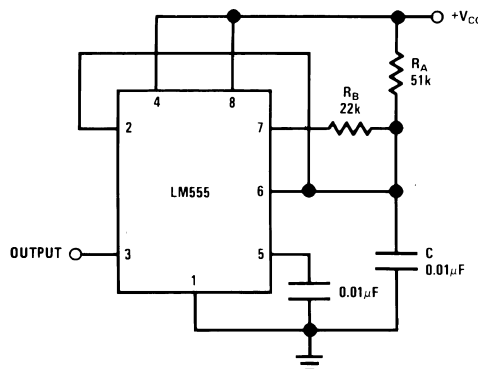
50% DUTY CYCLE OSCILLATOR

For a 50% duty cycle, the resistors R_A and R_B may be connected as in Figure 25. The time period for the output high is the same as previous, $t_1 = 0.693 R_A C$. For the output low it is $t_2 =$

$$\left[(R_A R_B) / (R_A + R_B) \right] C \ln \left[\frac{R_B - 2R_A}{2R_B - R_A} \right] \quad (8)$$

Thus the frequency of oscillation is:

$$f = \frac{1}{t_1 + t_2} \quad (9)$$

**Figure 25. 50% Duty Cycle Oscillator**

Note that this circuit will not oscillate if R_B is greater than $1/2 R_A$ because the junction of R_A and R_B cannot bring pin 2 down to $1/3 V_{CC}$ and trigger the lower comparator.

ADDITIONAL INFORMATION

Adequate power supply bypassing is necessary to protect associated circuitry. Minimum recommended is 0.1 μF in parallel with 1 μF electrolytic.

Lower comparator storage time can be as long as 10 μs when pin 2 is driven fully to ground for triggering. This limits the monostable pulse width to 10 μs minimum.

Delay time reset to output is 0.47 μs typical. Minimum reset pulse width must be 0.3 μs , typical.

Pin 7 current switches within 30ns of the output (pin 3) voltage.

REVISION HISTORY

Changes from Revision B (March 2013) to Revision C	Page
• Changed layout of National Data Sheet to TI format	12

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
LM555CM	ACTIVE	SOIC	D	8	95	TBD	Call TI	Call TI	0 to 70	LM 555CM	Samples
LM555CM/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	0 to 70	LM 555CM	Samples
LM555CMM	ACTIVE	VSSOP	DGK	8	1000	TBD	Call TI	Call TI	0 to 70	Z55	Samples
LM555CMM/NOPB	ACTIVE	VSSOP	DGK	8	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	0 to 70	Z55	Samples
LM555CMMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	0 to 70	Z55	Samples
LM555CMX	ACTIVE	SOIC	D	8	2500	TBD	Call TI	Call TI	0 to 70	LM 555CM	Samples
LM555CMX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	0 to 70	LM 555CM	Samples
LM555CN	ACTIVE	PDIP	P	8	40	TBD	Call TI	Call TI	0 to 70	LM 555CN	Samples
LM555CN/NOPB	ACTIVE	PDIP	P	8	40	Green (RoHS & no Sb/Br)	SN	Level-1-NA-UNLIM	0 to 70	LM 555CN	Samples
MC1455P1	ACTIVE	PDIP	P	8	40	TBD	Call TI	Call TI	0 to 70	LM 555CN	Samples
NE555V	ACTIVE	PDIP	P	8	40	TBD	Call TI	Call TI	0 to 70	LM 555CN	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM555CMM	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM555CMM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM555CMMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LM555CMX	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LM555CMX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM555CMM	VSSOP	DGK	8	1000	210.0	185.0	35.0
LM555CMM/NOPB	VSSOP	DGK	8	1000	210.0	185.0	35.0
LM555CMMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0
LM555CMX	SOIC	D	8	2500	367.0	367.0	35.0
LM555CMX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0

P (R-PDIP-T8)

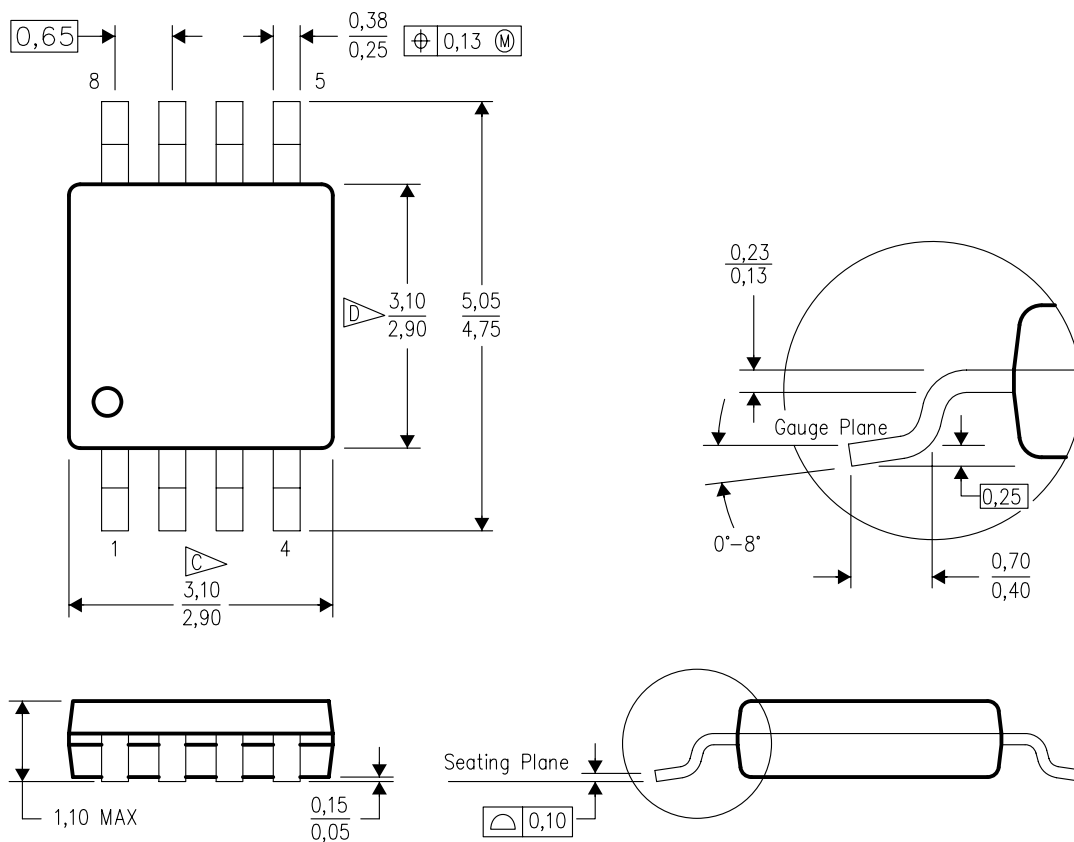
PLASTIC DUAL-IN-LINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-001 variation BA.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



4073329/E 05/06

NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- ☒ C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- ☐ D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - $\triangle C$ Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - $\triangle D$ Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AA.

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